

SJTA20N70C

Lead Free Package and Finish

Super-Junction MOSFET

Applications:

- Adaptor
- Charger
- •SMPS

Features:

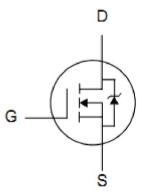
- RoHS Compliant
- . Low ON Resistance
- Low Gate Charge
- Peak Current vs Pulse Width Curve
- Inductive Switching Curves

Ordering Information

V _{DSS}	R _{DS(ON)} (Typ.)	I _D
700V	0.18Ω	20A

G_DTO-220F Packages Not to Scale

Pb



PART NUMBER	BRAND						
SJTA20N70C	TO-220F	IPS					

Absolute Maximum Ratings

T_C =25 °C unless otherwise specified

Symbol	Parameter	SJTA20N70C	Units
V _{DSS}	Drain-to-Source Voltage	700	V
I _D	Continuous Drain Current	20	Α
I _{DM}	Pulsed Drain Current, V _{GS} @10V (NOTE *2)	60	Α
D	Power Dissipation	34	W
P _D	Derating Factor above 25°C	0.27	W/°C
V _{GS}	Gate-to-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy	180	mJ
E _{AR}	Avalanche Energy ,Repetitive (NOTE *2)	1	mJ
I _{AR}	Avalanche Current (NOTE *2)	6	Α
TL	Maximum Temperature for Soldering	300	
$T_{\rm J}$ and $T_{\rm STG}$	Operating Junction and Storage Temperature Range (NOTE *1)	150,-55 to150	Ĉ

Thermal Resistance

Symbol	Parameter	Тур.	Units	Test Conditions
Б	Junction-to-Case	3.67	°C /W	Water cooled heatsink, P_{D} adjusted for a
$R_{ extsf{ heta}JC}$		5.07		peak junction temperature of +150℃.
R _{0JA}	Junction-to-Ambient	80		1 cubic foot chamber, free air.

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OFF Characteristics $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	700			V	V _{GS} =0V, I _D =250µA
I _{DSS}	Drain-to-Source Leakage Current			1	μA	V _{DS} =700V, V _{GS} =0V T _J =25℃
				100		V _{DS} =700V, V _{GS} =0V TJ=150℃
I _{GSS}	Gate-to-Source Forward Leakage			+100	nA nA	V _{GS} =+30V
	Gate-to-Source Reverse Leakage			-100		V _{GS} = -30V

ON Characteristics $T_J=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
R _{DS(ON)}	StaticDrain-to-Source		0.18	0.2	Ω	V _{GS} =10V, I _D =10A
	On-Resistance(NOTE *3)					
V _{GS(TH)}	Gate Threshold Voltage	2.5		4	V	V _{DS} =V _{GS} ,I _D =250µA
g _{fs}	Forward Transconductance(NOTE *3)		18.8		S	V _{DS} =10V, I _D =10A

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
C _{iss}	Input Capacitance		1605		pF	V _{GS} = 0V,V _{DS} = 50V f =1.0MHz
C _{oss}	Output Capacitance		225			
C _{rss}	Reverse Transfer Capacitance		14			
Qg	Total Gate Charge		41			I _D =20A,V _{DD} =560V V _{GS} = 10V
Q _{gs}	Gate-to-Source Charge		7.5		nC	
Q_{gd}	Gate-to-Drain ("Miller") Charge		15			

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
t _{d(ON)}	Turn-on Delay Time		13		- ns	V_{DD} =400V, I _D =20A, V _G =10V R _G =25Ω
t _{rise}	Rise Time		13			
t _{d(OFF)}	Turn-Off Delay Time		96			
t _{fall}	Fall Time		8			

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Source-Dra	In Diode Characteristics 10=2	25 C U	niess	Junerw	ise spe	cilied
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
	Continuous Source Current			20	^	
I _S	(Body Diode)			20	A	T _C =25℃
	Maximum Pulsed Current			70	А	
I _{SM}	(Body Diode)			70		
V _{SD}	Diode Forward Voltage			1.2	V	I _{SD} =20A, V _{GS} =0V
t _{rr}	Reverse Recovery Time		460		ns	I _F = I _S
Q _{rr}	Reverse Recovery Charge		8.2		uC	di/dt=100A/us

Source-Drain Diode Characteristics Tc=25°C

Tc=25°C unless otherwise specified

Notes:

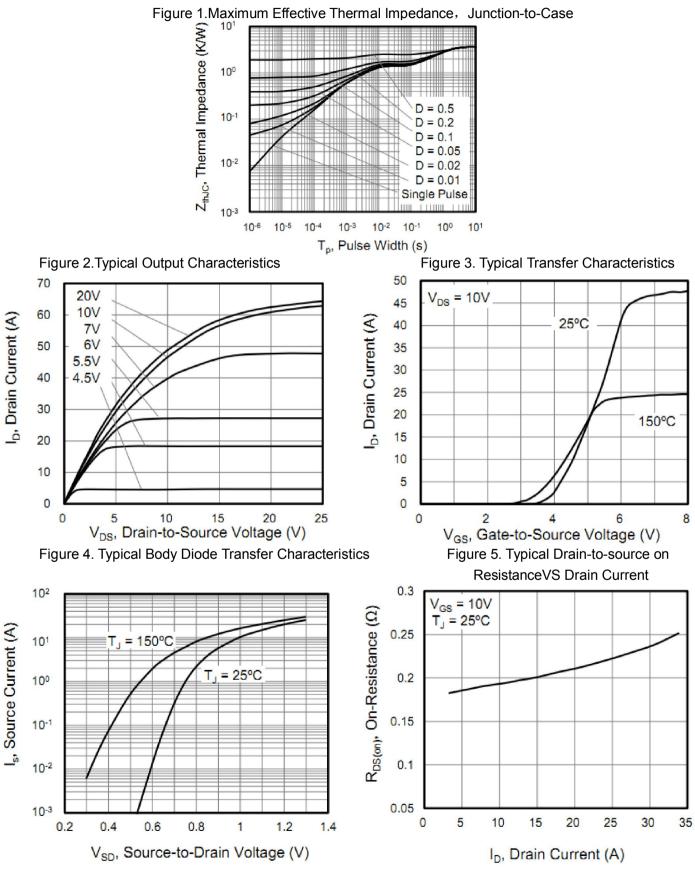
*1. T_J = +25℃ to +150℃.

*2. Repetitive rating; pulse width limited by maximum junction temperature.

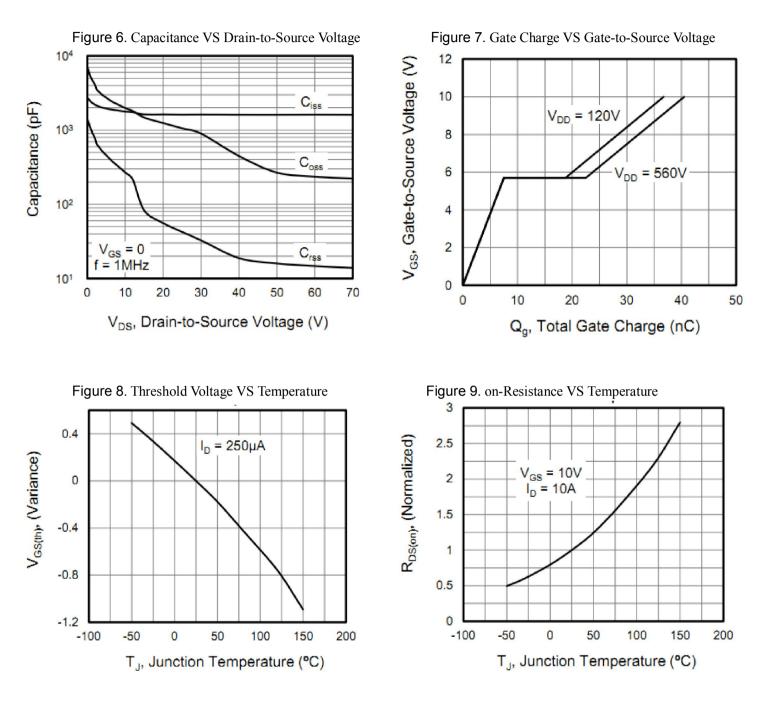
*3. Pulse width < 380μ s; duty cycle < 2%.



Characteristics Curve:

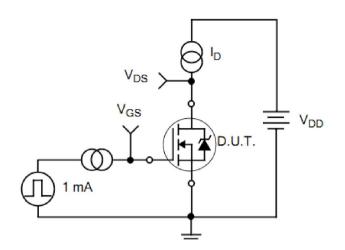








Test Circuits and Waveforms



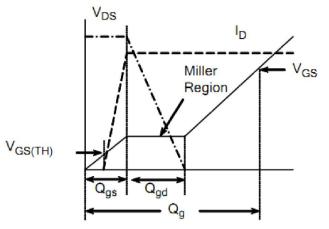
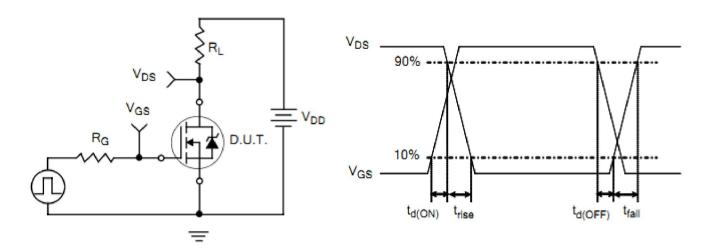
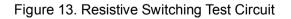
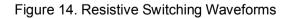


Figure 11. Gate Charge Test Circuit

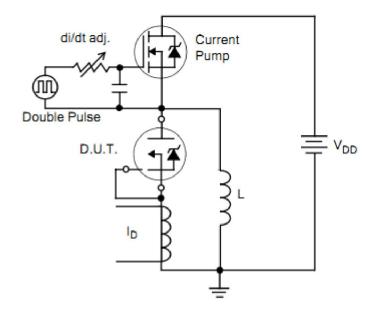
Figure 12. Gate Charge Waveforms











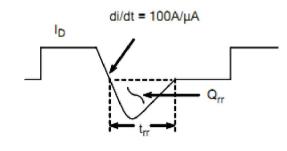


Figure 15. Diode Reverse Recovery Test Circuit

Figure 16. Diode Reverse Recovery Waveform

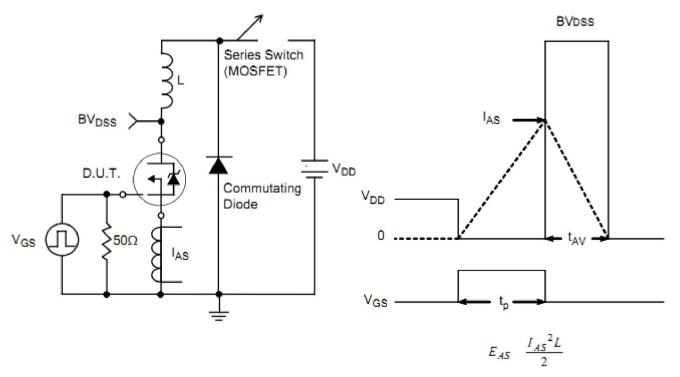


Figure 17. Unclamped Inductive Switching Test Circuit Figure 18. Unclamped Inductive Switching Waveform



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